



Test Report issued under
the responsibility of:



TEST REPORT
IEC 60950-1
Information technology equipment - Safety -
Part 1: General requirements

Report Reference No: E122103-A190-CB-2

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CB Testing Laboratory: UL Japan, Inc.

Address: 4383-326 Asama-cho, Ise-shi, Mie, 516-0021, Japan

Applicant's name: TDK-LAMBDA CORP
NAGAOKA TECHNICAL CENTER

Address: R&D DIV
2704-1 SETTAYA-MACHI
NAGAOKA-SHI
NIIGATA 940-1195 JAPAN

Test specification:

Standard: IEC 60950-1:2005 (Second Edition); Am1:2009 + Am2:2013

Test procedure: CB Scheme

Non-standard test method: N/A

Test Report Form No.: IEC60950_1F

Test Report Form originator: SGS Fimko Ltd

Master TRF: Dated 2014-02

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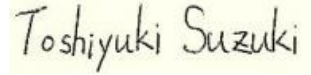
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Test item description	Switching Power Supply for Building-in
Trade Mark	TDK-Lambda
Manufacturer	TDK-LAMBDA CORP NAGAOKA TECHNICAL CENTER R&D DIV 2704-1 SETTAYA-MACHI NAGAOKA-SHI NIIGATA 940-1195 JAPAN
Model/Type reference	HWS1000L-X /YYYYYYY, SWS1000L-X /YYYYYYY, where X can be 3, 5, 12, 15, 24, 36, 48, or 60. And, /YYYYYYY can be /RF, /RFHC, /RFCO2, /HC, /HCCO2, /CO2, /RFHCCO2, /LLF, /LLFCO2, /LNF1 (only for X is 48) or blank HWS1000L-X /BATz, where X can be 36 or 60. And, z can be 3 digit max which consist of 0 to 9 and/or A to Z or blank.
Ratings	Input: 100-240 Vac, 13A, 50/60 Hz. Output: HWS1000L-3, SWS1000L-3, +3.3Vdc, 200A; HWS1000L-5, SWS1000L-5, +5Vdc (+4 - +6Vdc), 200A max; HWS1000L-12, SWS1000L-12, +12Vdc (+9.6 - +14.4Vdc), 88A max; HWS1000L-15, SWS1000L-15, +15Vdc (+12 - +19.5Vdc), 70A max; HWS1000L-24, SWS1000L-24, +24Vdc (+19.2 - +28.8Vdc), 44A max; HWS1000L-36, SWS1000L-36, +36Vdc (+28.8 - +43.2Vdc), 29A max; HWS1000L-48, SWS1000L-48, +48Vdc (+38.4 - +56Vdc), 22A max; HWS1000L-60, SWS1000L-60, +60Vdc (+48 - +66 Vdc), 17A max

Testing procedure and testing location:	
<input checked="" type="checkbox"/> CB Testing Laboratory	Testing location / address: UL Japan, Inc. 4383-326 Asama-cho, Ise-shi, Mie, 516-0021, Japan
<input type="checkbox"/> Associated CB Test Laboratory	Testing location / address:
	Tested by (name + signature): Tetsuo Iwasaki, Project Handler 
	Approved by (name + signature).....: Toshiyuki Suzuki, Reviewer 
<input type="checkbox"/> Testing Procedure: TMP/CTF Stage 1	Testing location / address:
	Tested by (name + signature): _____
	Approved by (name + signature).....: _____
<input type="checkbox"/> Testing Procedure: WMT/CTF Stage 2	Testing location / address:
	Tested by (name + signature): _____
	Witnessed by (name + signature) ...: _____
	Approved by (name + signature).....: _____
<input type="checkbox"/> Testing Procedure: SMT/CTF Stage 3 or 4	Testing location / address:
	Tested by (name + signature): _____
	Approved by (name + signature).....: _____
	Supervised by (name + signature) .: _____
<input type="checkbox"/> Testing Procedure: RMT	Testing location / address:
	Tested by (name + signature): _____
	Approved by (name + signature).....: _____
	Supervised by (name + signature) .: _____

List of Attachments	
National Differences (57 pages)	
Enclosures (49 pages)	
Summary Of Testing	
Unless otherwise indicated, all tests were conducted at UL Japan, Inc. 4383-326 Asama-cho, Ise-shi, Mie, 516-0021, Japan.	
Tests performed (name of test and test clause)	Testing location / Comments

Input: Single-Phase (1.6.2)

Heating (4.5.1, 1.4.12, 1.4.13)

Ball Pressure (4.5.5, 4.5)

Electric Strength (5.2.2)

Power Supply Output Short-Circuit/Overload (5.3.7)

Summary of Compliance with National Differences:

Countries outside the CB Scheme membership may also accept this report.

List of countries addressed: AR, AT, AU, BE, BG, BY, CA, CH, CN, CZ, DE, DK, ES, EU, FI, FR, GB, GR, HU, IE, IL, IN, IT, JP, KR, MY, NL, NO, NZ, PL, PT, RO, SA, SE, SG, SI, SK, UA, US

The product fulfills the requirements of: EN 60950-1:2006 + A1:2010 + A11:2009 + A12:2011 + A2:2013

Copy of Marking Plate - Refer to Enclosure titled Marking Plate for copy.